TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (U-MÖS III)

TPCP8101

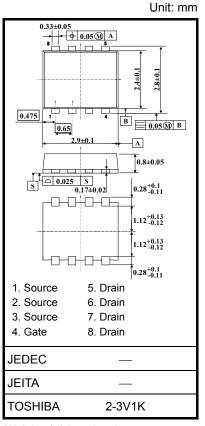
Notebook PC Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON-resistance: RDS (ON) = 24 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 14 \text{ S (typ.)}$
- Low leakage current: $IDSS = -10 \mu A (max) (VDS = -20 V)$
- Enhancement model: $V_{th} = -0.5 \text{ to } -1.2 \text{ V}$

 $(V_{DS} = -10 \text{ V}, I_{D} = -200 \mu\text{A})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristic			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	-20	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)			V_{DGR}	-20	V	
Gate-source voltage			V _{GSS}	± 8	V	
Drain current	DC	(Note 1)	I _D	-5.6	Α	
Drain current	Pulse	(Note 1)	I _{DP}	-22.4	A	
Drain power dissipation (t = 5 s) (Note 2a)			P_{D}	1.68	W	
Drain power dissipation	on	(t = 5 s) (Note 2b)	P_{D}	0.84	W	
Drain power dissipation (t = 5 s			E _{AS}	20.3	mJ	
Avalanche current			I _{AR}	-5.6	Α	
Repetitive avalanche energy (Note 4)			E _{AR}	0.168	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature	range		T _{stg}	-55~150	°C	



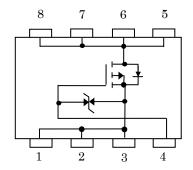
Weight: 0.017 g (typ.)

Note: For Notes 1 to 5, refer to the next page.

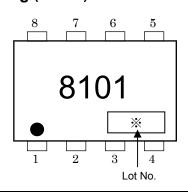
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Circuit Configuration



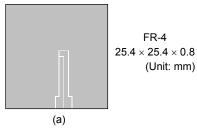
Marking (Note 5)

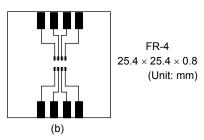


Thermal Characteristics

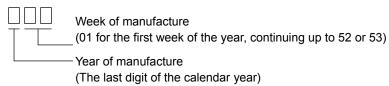
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 5 s) (Note 2a)	R _{th (ch-a)}	74.4	°C/W
Thermal resistance, channel to ambient (t = 5 s) (Note 2b)	R _{th (ch-a)}	148.8	°C/W

- Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.
- Note 2: (a) Device mounted on a glass-epoxy board (a)
- (b) Device mounted on a glass-epoxy board (b)





- Note 3: $V_{DD} =$ -16 V, $T_{ch} = 25^{\circ}C$ (initial), L = 0.5 mH, $R_{G} = 25~\Omega$, $I_{AR} =$ -5.6 A
- Note 4: Repetitive rating: pulse width limited by maximum channel temperature.
- Note 5: on the lower left of the marking indicates Pin 1.
 - * Weekly code (three digits):





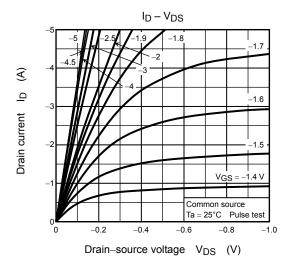
Electrical Characteristics (Ta = 25°C)

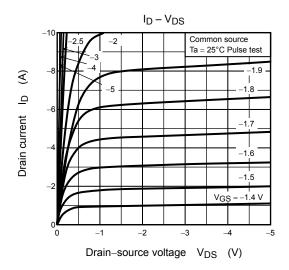
www.DataSheet4U.com

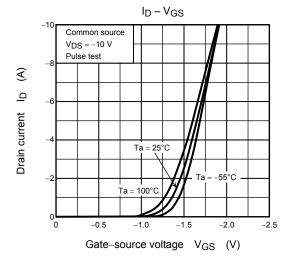
Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Drain cutoff curre	ent	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V	_	_	-10	μА
Drain-source bre	akdown voltago	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-20	±10 10	V	
Dialii-source bre	akdown voltage	V _(BR) DSX	$I_D = -10 \text{ mA}, V_{GS} = 8 \text{ V}$	-12		v	
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A}$	-0.5	_	-1.2	V
			V _{GS} = -1.8 V, I _D = -1.4 A	<u> </u>		90	mΩ
Drain-source ON-resistance	R _{DS} (ON)	$V_{GS} = -2.5 \text{ V}, I_D = -2.8 \text{ A}$	_	36	41		
			$V_{GS} = -4.5 \text{ V}, I_D = -2.8 \text{ A}$	_	24	30	
Forward transfer	rward transfer admittance		$V_{DS} = -10 \text{ V}, I_D = -2.8 \text{ A}$	7	14	_	S
Input capacitance		C _{iss}			1550	_	pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	215	_	
Output capacitan	· · · · · · · · · · · · · · · · · · ·			_	265	_	
Rise time	Rise time	t _r	V _{GS} 0 V] [I _D = -2.8 A	_	7	_	
Out the bits of the co	Turn-on time	t _{on}	V _{GS} -5 V I _D = -2.8 A V _{OUT} V _{GS} V	_	13	±10 -101.2 90 41 30	
Switching time	Fall time	t _f	4.7.5 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	_	21	_	ns
	Turn-off time	t _{off}	$V_{DD} \simeq -10 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu\text{s}$	_	68	_	_
Total gate charge (gate-source plus	otal gate charge gate-source plus gate-drain)		V _{DD} ≈ -16 V, V _{GS} = -5 V,	_	19	_	
Gate-source charge		Q _{gs}	$I_D = -5.6 \text{ A}$	_	14		nC
Gate-drain ("Mille	er") charge	Q _{gd}		_	5		

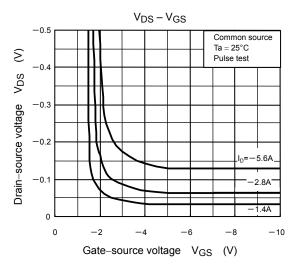
Source-Drain Ratings and Characteristics (Ta = 25°C)

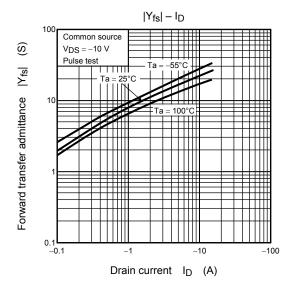
Charact	teristic	Symbol	Test Condition	Min Typ. Ma		Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	ı	_	-22.4	А
Forward voltage ((diode)	V_{DSF}	$I_{DR} = -5.6 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	1.2	V

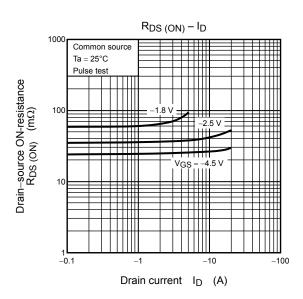




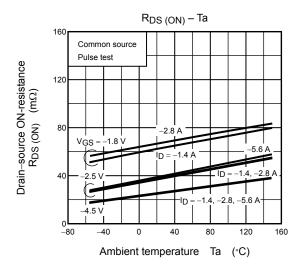


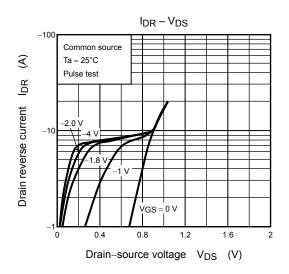


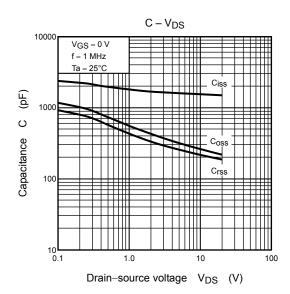


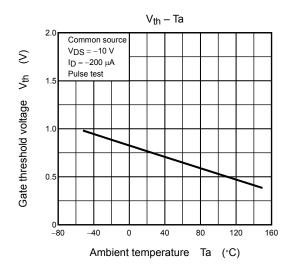


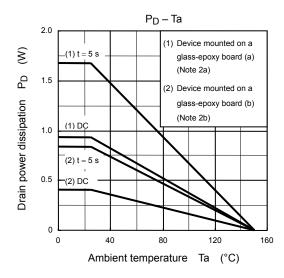
4

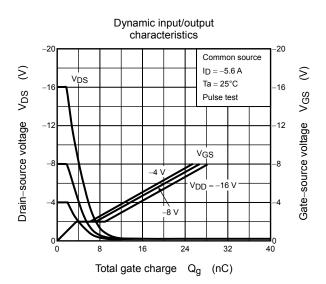


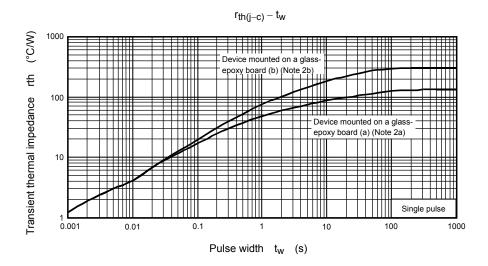


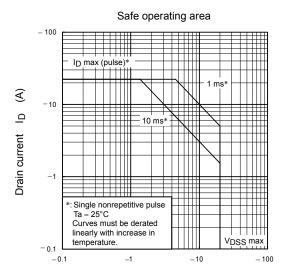












Drain-sour

TOSHIBA TPCP8101

www.DataSheet4U.com

RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS
 compatibility. Please use these products in this document in compliance with all applicable laws and regulations
 that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
 occurring as a result of noncompliance with applicable laws and regulations.